## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10826162	ZHANG ET AL.
Examiner	Art Unit
FLEURANTIN, JEAN B	2162

SEARCHED							
Class	Subclass	Date	Examiner				
707	1-10, 100-104.1 & 200-206	4/26/2007	JBF				
382	218, 220 & 225	4/26/2007	JBF				

SEARCH NOTES					
Search Notes	Date	Examiner			
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).	4/26/2007	JBF			
707/ccls & Inventors Search & all related applications have been reviewed.	4/26/2007	JBF			
NPL - ACM & IEEE	4/26/2007	JBF			

INTERFERENCE SEARCH							
Class		Subclass	Date	Examiner			
707	3, 4 & 5		4/26/2007	JBF			